









**TMP61-Q1** SNIS210G - APRIL 2019 - REVISED NOVEMBER 2023

# TMP61-Q1 Automotive Grade, ±1% 10-kΩ Linear Thermistor With 0402 and 0603 **Package Options**

### 1 Features

- **Automotive Qualifications** 
  - AEC-Q100 Grade 1: –40°C to 125°C
  - AEC-Q100 Grade 0 (DYA): –40°C to 150°C
  - AEC-Q100 Grade 0 (ELPG): –40°C to 170°C
- AEC-Q200 Tested
- Functional Safety-Capable
  - Documentation available to aid functional safety system design
- Silicon-based thermistor with a positive temperature coefficient (PTC)
- Linear resistance change across temperature
- 10-kΩ nominal resistance at 25°C (R25)
  - ±1% maximum (0°C to 70°C)
- Consistent sensitivity across temperature
  - 6400 ppm/°C TCR (25°C)
  - 0.2% typical TCR tolerance across temperature
- Fast thermal response time of 0.6 s (DEC)
- Long lifetime and robust performance
  - Built-in fail-safe in case of short-circuit failures
  - 0.5% typical long term sensor drift

## 2 Applications

- · Thermal compensation
  - Display backlight
  - Battery management systems
- Thermal threshold detection
  - Motor control
  - On-board chargers & DC-DC converters

## 3 Description

Get started today with the Thermistor Design Tool, offering complete resistance vs temperature table (R-T table) computation, other helpful methods to derive temperature and example C-code.

The TMP61-Q1 linear thermistor offers linearity and consistent sensitivity across temperature to enable simple and accurate methods for temperature conversion. The low power consumption and a small thermal mass of the device minimize self-heating.

With built-in fail-safe behaviors at high temperatures and powerful immunity to environmental variation. these devices are designed for a long lifetime of high performance. The small size of the TMP6 series also allows for close placement to heat sources and quick response times.

Take advantage of benefits over NTC thermistors such as no extra linearization circuitry, minimized calibration, less resistance tolerance variation, larger sensitivity at high temperatures, and simplified conversion methods to save time and memory.

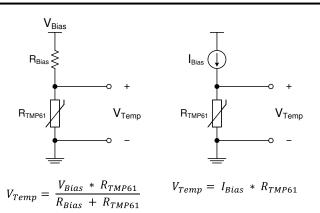
The TMP61-Q1 is currently available in a 0402 X1SON package, a 0603 SOT-5X3 package, and a 2-pin through-hole TO-92S package.

#### **Package Information**

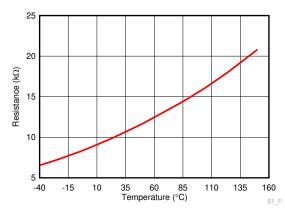
PART NUMBER PACKAGE <sup>(1)</sup>		PACKAGE SIZE <sup>(2)</sup>	
	DEC (X1SON, 2)	1.00 mm × 0.60 mm	
TMP61-Q1	LPG (TO-92S, 2)	4.00 mm × 1.52 mm	
	DYA (SOT-5X3, 2)	1.60 mm × 0.80 mm	

- For all available packages, see the orderable addendum at the end of the data sheet.
- The package size (length × width) is a nominal value and includes pins, where applicable.





**Typical Implementation Circuits** 



**Typical Resistances vs Ambient Temperature** 

Submit Document Feedback

Copyright © 2023 Texas Instruments Incorporated



## **Table of Contents**

1 Features	1	8 Application and Implementation	12
2 Applications	1	8.1 Application Information	12
3 Description	1	8.2 AEC-Q200 Qualifications	12
4 Device Comparison		8.3 Typical Application	1 <mark>2</mark>
5 Pin Configuration and Functions	4	8.4 Power Supply Recommendations	18
6 Specifications	<mark>5</mark>	8.5 Layout	18
6.1 Absolute Maximum Ratings		9 Device and Documentation Support	<mark>2</mark> 0
6.2 ESD Ratings	5	9.1 Documentation Support	20
6.3 Recommended Operating Conditions	5	9.2 Receiving Notification of Documentation Updates	s <mark>20</mark>
6.4 Thermal Information	6	9.3 Support Resources	20
6.5 Electrical Characteristics	7	9.4 Trademarks	20
6.6 Typical Characteristics	8	9.5 Glossary	20
7 Detailed Description	10	9.6 Electrostatic Discharge Caution	20
7.1 Overview	10	10 Revision History	20
7.2 Functional Block Diagram		11 Mechanical, Packaging, and Orderable	
7.3 Feature Description	11	Information	22
7.4 Device Functional Modes			

# **4 Device Comparison**

## Table 4-1. Device Comparison

PART NUMBER	R25 TYP	R25 %TOL	RATING	T <sub>A</sub>	PACKAGE OPTIONS
				–40°C to 125°C	X1SON / DEC (0402)
TMP61	10k	1%	Catalog	–40°C to 150°C	SOT-5X3 / DYA (0603)
				–40°C to 150°C	TO-92S / LPG
			Automotive Grade-1	–40°C to 125°C	X1SON / DEC (0402)
TMP61-Q1	10k	1%	Automotive Grade-0	–40°C to 150°C	SOT-5X3 / DYA (0603)
				–40°C to 170°C	TO-92S / LPG
TMP63	100%	1%	Catalan	–40°C to 125°C	X1SON / DEC (0402)
TIVIPOS	100k	170	Catalog	–40°C to 150°C	SOT-5X3 / DYA (0603)
TMDC2 O4	4001	1%	Automotive Grade-1	–40°C to 125°C	X1SON / DEC (0402)
TMP63-Q1	100k	1%	Automotive Grade-0	–40°C to 150°C	SOT-5X3 / DYA (0603)
TMDC4	471.	40/	Catalan	–40°C to 125°C	X1SON / DEC (0402)
TMP64	47k	1%	Catalog	-40°C to 150°C	SOT-5X3 / DYA (0603)
TMD64_04	471	10/	Automotive Grade-1	-40°C to 125°C	X1SON / DEC (0402)
TMP64-Q1	47k	1%	Automotive Grade-0	-40°C to 150°C	SOT-5X3 / DYA (0603)



# **5 Pin Configuration and Functions**

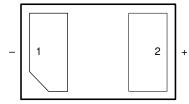
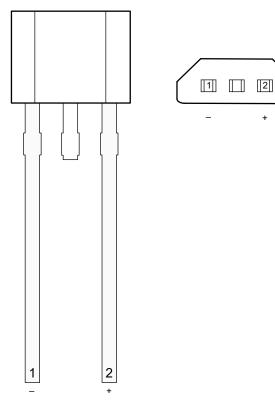


Figure 5-1. DEC Package 2-Pin X1SON Top View



ID mark is identified as a dot in the ID area and it denotes pin 1. Figure 5-2. DYA Package 2-Pin SOT-5X3 Top View



Front view is described as chamfers of TO-92S facing the user. Bottom view is described as pins coming out of the page.

Figure 5-3. LPG Package 2-Pin TO-92S Front View, Bottom View

Table 5-1. Pin Functions

P	IN	TYPE	DESCRIPTION	
NAME	NO.	IIFE	DESCRIPTION	
_	1		Thermistor (–) and (+) terminals. For proper operation, ensure a positive bias where the +	
+	2	_	terminal is at a higher voltage potential than the – terminal.	



## **6 Specifications**

## **6.1 Absolute Maximum Ratings**

over operating free-air temperature range (unless otherwise noted) (1)

	1			
		MIN	MAX	UNIT
Voltage across the device			6	V
Junction temperature (T <sub>J</sub> )	Automotive Grade 1 (DEC, DYA QLPG package)	-65	155	°C
Junction temperature (T <sub>J</sub> )	Automotive Grade 0 (ELPG package)	-65	175	°C
Current through the device			450	μΑ
Storage temperature (T <sub>stg</sub> )		-65	175	°C

<sup>(1)</sup> Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

## 6.2 ESD Ratings

			VALUE	UNIT
V	Electrostatic discharge	Human-body model (HBM), per AEC Q100-002 <sup>(1)</sup> HBM classification level 2	±2000	V
V <sub>(ESD)</sub>	Electrostatic discharge	Charged-device model (CDM), per AEC Q100-011 CDM classification level C6	±1000	V

<sup>(1)</sup> AEC Q100-002 indicates that HBM stressing shall be in accordance with the ANSI/ESDA/JEDEC JS-001 specification.

## **6.3 Recommended Operating Conditions**

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM MAX	UNIT
$V_{Sns}$	Voltage Across Pins 2 (+) and 1 (–)	0	5.5	V
	Current passing through the device T <sub>A</sub> = -40 °C to 150 °C	0	400	
I <sub>Sns</sub>	Current passing through the device T <sub>A</sub> = 150 °C to 170 °C	50	250	μA
	Operating free-air temperature (Automotive Grade 1 DEC, QLPG Package)	-40	125	
T <sub>A</sub>	Operating free-air temperature (Automotive Grade 0 DYA Package)	-40	150	°C
	Operating free-air temperature (Automotive Grade 0 ELPG Package) <sup>(1)</sup> (2)	-40	170	

<sup>(1)</sup> HTOL was performed at 160 °C for 2300 hours and 175 °C for 24 hours

Copyright © 2023 Texas Instruments Incorporated

<sup>(2)</sup> HTSL for was performed at 175 °C for 2000 hours



### **6.4 Thermal Information**

	THERMAL METRIC <sup>(1)</sup> (2)	DEC (X1SON)	LPG (TO-92S)	DYA (SOT-5X3)	UNIT
		2 PINS	2 PINS	2 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance <sup>(3)</sup> (4)	443.4	215	742.9	°C/W
R <sub>0JC(top)</sub>	Junction-to-case (top) thermal resistance	195.7	99.9	315.8	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	254.6	191.7	506.2	°C/W
$\Psi_{JT}$	Junction-to-top characterization parameter	19.9	35.1	109.3	°C/W
$\Psi_{JB}$	Junction-to-board characterization parameter	254.5	191.7	500.4	°C/W
R <sub>0JC(bot)</sub>	Junction-to-case (bottom) thermal resistance	-	_	_	°C/W

- (1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.
- (2) For information on self-heating and thermal response time see Layout Guidelines section.
- (3) The junction to ambient thermal resistance (R0<sub>JA</sub>) under natural convection is obtained in a simulation on a JEDEC-standard, High-K board as specified in JESD51-7, in an environment described in JESD51-2. Exposed pad packages assume that thermal vias are included in the PCB, per JESD 51-5.
- (4) Changes in output due to self heating can be computed by multiplying the internal dissipation by the thermal resistance.

## **6.5 Electrical Characteristics**

 $T_A$  = -40°C to 125°C (TMP61Q),  $T_A$  = -40°C to 170°C (TMP61E),  $I_{Sns}$  = 200  $\mu$ A (unless otherwise noted)

	PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
R <sub>25</sub>	Thermistor Resistance at 25°C <sup>(1)</sup>	T <sub>A</sub> = 25°C	9.9	10	10.1	kΩ
R <sub>TOL</sub>	Resistance Tolerance <sup>(1)</sup>	T <sub>A</sub> = 25°C	-1		1	%
Ъ	Resistance Tolerance <sup>(1)</sup>	T <sub>A</sub> = 0°C to 70°C	-1		1	%
R <sub>TOL</sub>	Resistance Tolerance(**)	$T_A = -40^{\circ}C \text{ to } 150^{\circ}C$	-1.5		1.5	%
R <sub>TOL</sub>	Resistance Tolerance <sup>(1)</sup>	T <sub>A</sub> = 150°C to 170°C	-2.5		2.5	%
TCR <sub>-35</sub>		T1 = -40°C, T2 = -30°C		+6220		
TCR <sub>25</sub>	Temperature Coefficient of Resistance	T1 = 20°C, T2 = 30°C		+6400		ppm/°C
TCR <sub>85</sub>		T1 = 80°C, T2 = 90°C		+5910		
TCR <sub>-35</sub> %		T1 = -40°C, T2 = -30°C		±0.4		
TCR <sub>25</sub> %	Temperature Coefficient of Resistance Tolerance	T1 = 20°C, T2 = 30°C		±0.2		%
TCR <sub>85</sub> %	Tolerande	T1 = 80°C, T2 = 90°C		±0.3		
		96 hours continuous operation RH = 85 %, T <sub>A</sub> = 130°C, V <sub>Bias</sub> = 5.5V	-1	0.1	1	
	Sensor Long Term Drift (Reliability)	600 hours continuous operation at T <sub>A</sub> = 150°C V <sub>Bias</sub> = 5.5V, DEC Package	-1	0.5	1.8	-
ΔR		600 hours continuous operation at T <sub>A</sub> = 150 °C V <sub>Bias</sub> = 5.5V, DYA Package	-1	0.2	1.2	
		1000 hours continuous operation at T <sub>A</sub> = 150 °C V <sub>Bias</sub> = 5.5V, DYA Package	-1	0.2	1.2	
		1000 hours continuous operation at T <sub>A</sub> = 150°C V <sub>Bias</sub> = 5.5V, QLPG Package	-0.5	0.5	1.4	
ΔR	Sensor Long Term Drift (Reliability)	2300 hours continuous operation at $T_A$ = 160°C 24 hours continuous operation at $T_A$ = 175°C $V_{Bias}$ = 5.5V, ELPG Package	-2	1.1	4	%
t <sub>RES</sub> (stirred liquid)	Thermal response to 63 % (DEC Package)	T1 = 25°C in Still Air to T2 = 125°C in Stirred Liquid		0.6		s
t <sub>RES</sub> (stirred liquid)	Thermal response to 63 % (LPG Package)	T1 = 25°C in Still Air to T2 = 125°C in Stirred Liquid		2.9		s
t <sub>RES (still air)</sub>	Thermal response to 63 % (DEC Package)	T1 = 25°C to T2 = 70°C in Still Air		3.2		s
t <sub>RES (still air)</sub>	Thermal response to 63 % (LPG Package)	T1 = 25°C to T2 = 70°C in Still Air		20		s

<sup>(1)</sup> Limits defined based on 4th order equation, tolerance will change with 'Sensor Long Term Drift' specification.



## **6.6 Typical Characteristics**

at  $T_A = 25$ °C, (unless otherwise noted)

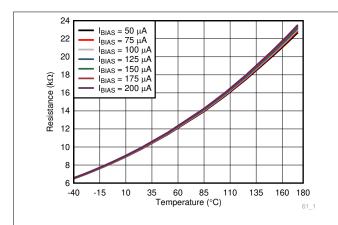
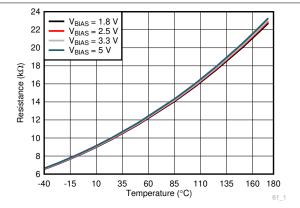


Figure 6-1. Automotive Grade 0 Resistance vs Ambient Temperature Using Multiple Bias Currents



 $R_{BIAS}$  = 10 k $\Omega$  with ±0.01% tolerance

Figure 6-2. Automotive Grade 0 Resistance vs Ambient Temperature Using Multiple Bias Voltages

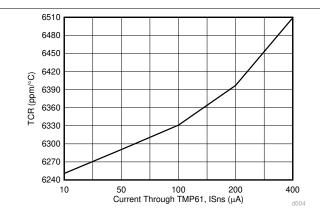
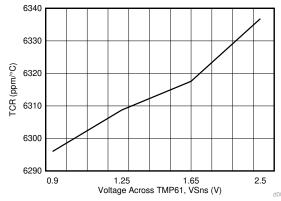


Figure 6-3. TCR vs Sense Currents (I<sub>SNS</sub>)



 $V_{Sns}$  = 1.8 V, 2.5 V, 3.3 V, and 5.0 V,  $R_{Bias}$  = 10  $k\Omega$  with  $\pm 0.01\%$  Tolerance

Figure 6-4. TCR vs Sense Voltages, V<sub>Sns</sub>

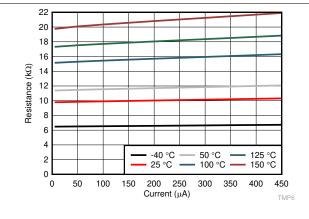
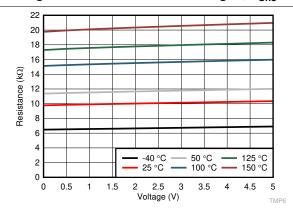


Figure 6-5. Supply Dependence Resistance vs Bias Current



 $R_{Bias} = 10 \text{ k}\Omega \text{ (} \pm 0.01\% \text{ tolerance)}$ 

Figure 6-6. Supply Dependence vs Bias Voltage

Submit Document Feedback

Copyright © 2023 Texas Instruments Incorporated

## www.ti.com

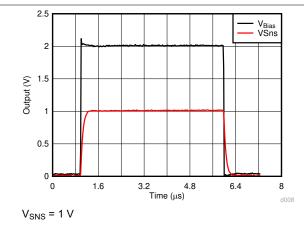


Figure 6-7. Step Response

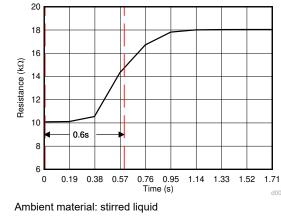


Figure 6-8. Thermal Response Time (DEC package)

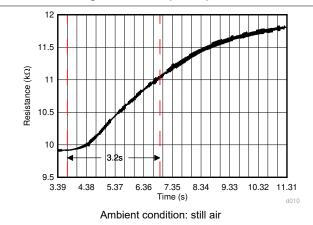


Figure 6-9. Thermal Response Time (DEC and DYA Package)

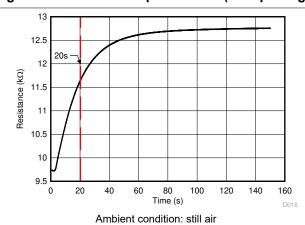


Figure 6-10. Thermal Response Time (LPG Package)

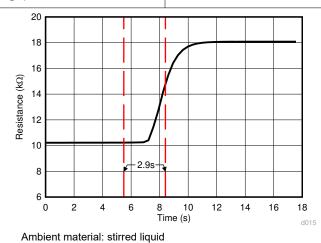


Figure 6-11. Thermal Response Time (LPG Package)

## 7 Detailed Description

### 7.1 Overview

The TMP61-Q1 silicon linear thermistor has a linear positive temperature coefficient (PTC) that results in a uniform and consistent temperature coefficient resistance (TCR) across a wide operating temperature range. TI uses a special silicon process where the doping level and active region areas devices control the key characteristics (the temperature coefficient resistance (TCR) and nominal resistance (R25)). The device has an active area and a substrate due to the polarized terminals. Connect the positive terminal to the highest voltage potential.

Unlike an NTC, which is a purely resistive device, the TMP61-Q1 resistance is affected by the current across the device and the resistance changes when the temperature changes. In a voltage divider circuit, TI recommends to maintain the top resistor value at 10 k $\Omega$ . Changing the top resistor value or the V<sub>BIAS</sub> value changes the resistance vs temperature table (R-T table) of the TMP61-Q1, and subsequently the polynomials as described in the *Design Requirements* section. Consult the *TMP61-Q1 R-T table* section for more information.

Equation 1 can help the user approximate the TCR.

$$TCR = \frac{\left(R_{T2} - R_{T1}\right)}{\left(T2 - T1\right) \times R_{\underbrace{\left(T2 - T1\right)}{2}}} \tag{1}$$

where

· TCR is in ppm/°C

Key terms and definitions:

- I<sub>SNS</sub>: Current flowing through the TMP61-Q1 device
- V<sub>SNS</sub>: Voltage across the two TMP61-Q1 terminal
- I<sub>BIAS</sub>: Current supplied by the biasing circuit.
- V<sub>BIAS</sub>: Voltage supplied by the biasing circuit.
- V<sub>TEMP</sub>: Output voltage that corresponds to the measured temperature. Note that this is different from V<sub>SNS</sub>. In
  the use case of a voltage divider circuit with the TMP61-Q1 in the high side, V<sub>TEMP</sub> is measured across R<sub>BIAS</sub>.

### 7.2 Functional Block Diagram

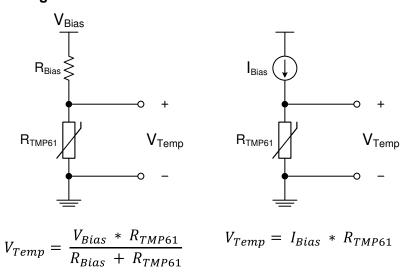


Figure 7-1. Typical Implementation Circuits

## 7.3 Feature Description

#### 7.3.1 TMP61-Q1 R-T table

The TMP61-Q1 R-T table must be re-calculated for any change in the bias voltage, bias resistor, or bias current. TI provides a Thermistor Design Tool to calculate the R-T table. The system designer must always validate the calculations provided.

#### 7.3.2 Linear Resistance Curve

The TMP61-Q1 has good linear behavior across the whole temperature range as shown in *Typical Characteristics*. This range allows a simpler resistance-to-temperature conversion method that reduces look-up table memory requirements. The linearization circuitry or midpoint calibration associated with traditional NTCs is not necessary with the device.

The linear resistance across the entire temperature range allows the device to maintain sensitivity at higher operating temperatures.

#### 7.3.3 Positive Temperature Coefficient (PTC)

The TMP61-Q1 has a positive temperature coefficient. As temperature increases the device resistance increases leading to a reduction in power consumption of the bias circuit. In comparison, a negative coefficient system increases power consumption with temperature as the resistance decreases.

The TMP61-Q1 benefits from the reduced power consumption of the bias circuit with less self-heating than a typical NTC system.

#### 7.3.4 Built-In Fail Safe

The TMP6 family feature a positive temperature coefficient. During a short-to-supply condition, the thermistor will have increased current and power dissipated. Due to the positive temperature slope, the TMP6 will increase resistance and limit self-heating by design.

In contrast, a NTC would continually reduce resistance due to self-heating leading to a positive feedback of increasing power dissipation and decreasing resistance.

### 7.4 Device Functional Modes

The device operates in only one mode when operated within the *Recommended Operating Conditions*.

## 8 Application and Implementation

#### Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

### 8.1 Application Information

The TMP61-Q1 is a positive temperature coefficient (PTC) linear silicon thermistor. The device behaves as a temperature-dependent resistor, and may be configured in a variety of ways to monitor temperature based on the system-level requirements. The TMP61-Q1 has a nominal resistance at 25°C (R25) of 9.82 10 k $\Omega$  with ±1% maximum tolerance, a maximum operating voltage of 5.5 V (V<sub>SNS</sub>), and maximum supply current of 400  $\mu$ A (I<sub>SNS</sub>). This device may be used in a variety of applications to monitor temperature close to a heat source with the very small DEC package option compatible with the typical 0402 (inch) footprint. Some of the factors that influence the total measurement error include the ADC resolution (if applicable), the tolerance of the bias current or voltage, the tolerance of the bias resistance in the case of a voltage divider configuration, and the location of the sensor with respect to the heat source.

### 8.2 AEC-Q200 Qualifications

Although qualified under AEC-Q100, the TMP61-Q1 is also tested per the AEC-Q200 qualifications and passes all required testing with the exception of the Terminal Strength (SMD) / Shear Test. For this test the following results were observed:

- DEC Package passed up to 200g stress force
- · DYA Package passed up to 400g stress force

The LPG package is not tested for AEC-Q200 qualifications.

### 8.3 Typical Application

#### 8.3.1 Thermistor Biasing Circuits

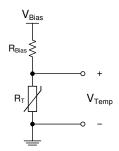


Figure 8-1. Voltage Biasing Circuit With Linear Thermistor

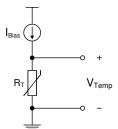
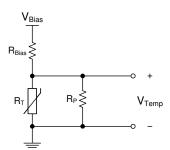


Figure 8-2. Current Biasing Circuit With Linear Thermistor



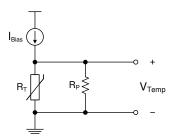


Figure 8-3. Voltage Biasing Circuit With Non-Linear Thermistor

Figure 8-4. Current Biasing Circuit With Non-Linear
Thermistor

### 8.3.1.1 Design Requirements

Existing thermistors, in general, have a non-linear temperature versus resistance curve. To linearize the thermistor response, the engineer can use a voltage linearization circuit with a voltage divider configuration, or a resistance linearization circuit by adding another resistance in parallel with the thermistor, R<sub>P</sub>. The *Thermistor Biasing Circuits* section highlights the two implementations where R<sub>T</sub> is the thermistor resistance. To generate an output voltage across the thermistor, the engineer can use a voltage divider circuit with the thermistor placed at either the high side (close to supply) or low side (close to ground), depending on the desired voltage response (negative or positive). Alternatively, the resistor can be biased directly using a precision current source (yielding the highest accuracy and voltage gain). It is common to use a voltage divider with thermistors because of its simple implementation and lower cost. The TMP61-Q1, on the other hand, has a linear positive temperature coefficient (PTC) of resistance such that the voltage measured across it increases linearly with temperature. As such, the need for linearization circuits is no longer a requirement, and a simple current source or a voltage divider circuit can be used to generate the temperature voltage.

This output voltage can be interpreted using a comparator against a voltage reference to trigger a temperature trip point that is either tied directly to an ADC to monitor temperature across a wider range or used as feedback input for an active feedback control circuit.

The voltage across the device, as described in Equation 2, can be translated to temperature using either a lookup table method (LUT) or a fitting polynomial, V(T). The Thermistor Design Tool must be used to translate Vtemp to Temperature. The temperature voltage must first be digitized using an ADC. The necessary resolution of this ADC is dependent on the biasing method used. Additionally, for best accuracy, tie the bias voltage ( $V_{BIAS}$ ) to the reference voltage of the ADC to create a measurement where the difference in tolerance between the bias voltage and the reference voltage cancels out. The application can also include a low-pass filter to reject system level noise. In this case, place the filter as close to the ADC input as possible.

#### 8.3.1.2 Detailed Design Procedure

The resistive circuit divider method produces an output voltage ( $V_{TEMP}$ ) scaled according to the bias voltage ( $V_{BIAS}$ ). When  $V_{BIAS}$  is also used as the reference voltage of the ADC, any fluctuations or tolerance error due to the voltage supply are cancelled and do not affect the temperature accuracy (as shown in Figure 8-5). Use Equation 2 to calculate the output voltage ( $V_{TEMP}$ ) based on the variable resistance of the TMP61-Q1 ( $R_{TMP61}$ ) and bias resistor ( $R_{BIAS}$ ). Use Equation 3 to calculate the ADC code that corresponds to that output voltage, ADC full-scale range, and ADC resolution.



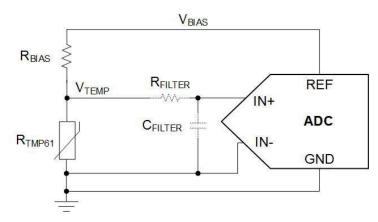


Figure 8-5. TMP61-Q1 Voltage Divider With an ADC

$$V_{TEMP} = V_{BIAS} \times \left( \frac{R_{TMP61}}{R_{TMP61} + R_{BIAS}} \right)$$
 (2)

$$ADC Code = \frac{V_{TEMP}}{FSR} 2^{n}$$
(3)

#### where

- FSR is the full-scale range of the ADC, which is the voltage at REF to GND (V<sub>REF</sub>)
- · n is the resolution of the ADC

Equation 4 shows when  $V_{REF} = V_{BIAS}$ ,  $V_{BIAS}$  cancels out.

$$ADC \ Code = \frac{V_{BIAS} \times \left(\frac{R_{TMP61}}{R_{TMP61} + R_{BIAS}}\right)}{V_{BIAS}} 2^n = \left(\frac{R_{TMP61}}{R_{TMP61} + R_{BIAS}}\right) 2^n \tag{4}$$

Use a polynomial equation or a LUT to extract the temperature reading based on the ADC code read in the microcontroller. Use the Thermistor Design Tool to translate the TMP61-Q1 resistance to temperature.

The cancellation of  $V_{BIAS}$  is one benefit to using a voltage-divider (ratiometric approach), but the sensitivity of the output voltage of the divider circuit cannot increase much. Therefore, this application design does not use all of the ADC codes due to the small voltage output range compared to the FSR. This application is very common, however, and is simple to implement.

A current source-based circuit, such as the one shown in Figure 8-6, offers better control over the sensitivity of the output voltage and achieve higher accuracy. In this case, the output voltage is simply V = I × R. For example, if a current source of 40  $\mu$ A is used with the device, the output voltage spans approximately 5.5 V and has a gain up to 40 mV/°C. Having control over the voltage range and sensitivity allows for full use of the ADC codes and full-scale range. Figure 8-7 shows the temperature voltage for various bias current conditions. Similar to the ratiometric approach, if the ADC has a built-in current source that shares the same bias as the reference voltage of the ADC, the tolerance of the supply current cancels out. In this case, a precision ADC is not required. This method yields the best accuracy, but can increase the system implementation cost.

Product Folder Links: TMP61-Q1

Copyright © 2023 Texas Instruments Incorporated



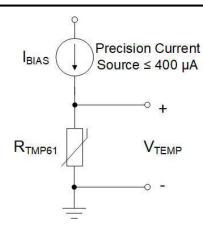


Figure 8-6. TMP61-Q1 Biasing Circuit With Current Source

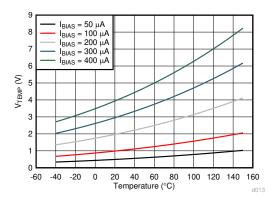


Figure 8-7. TMP61-Q1 Temperature Voltage With Varying Current Sources

In comparison to the non-linear NTC thermistor in a voltage divider, the TMP61-Q1 has an enhanced linear output characteristic. The two voltage divider circuits with and without a linearization parallel resistor,  $R_P$ , are shown in Figure 8-8. Consider an example where  $V_{BIAS}$  = 5 V,  $R_{BIAS}$  = 100 k $\Omega$ , and a parallel resistor ( $R_P$ ) is used with the NTC thermistor ( $R_{NTC}$ ) to linearize the output voltage with an additional 100-k $\Omega$  resistor. The output characteristics of the voltage dividers are in Figure 8-9. The device produces a linear curve across the entire temperature range while the NTC curve is only linear across a small temperature region. When the parallel resistor ( $R_P$ ) is added to the NTC circuit, the added resistor makes the curve much more linear but greatly affects the output voltage range.

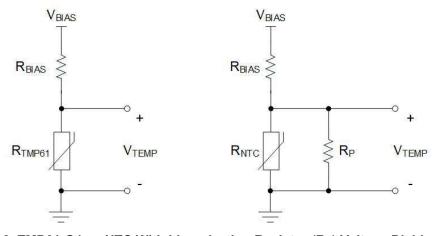


Figure 8-8. TMP61-Q1 vs NTC With Linearization Resistor (RP) Voltage Divider Circuits

Copyright © 2023 Texas Instruments Incorporated

Submit Document Feedback

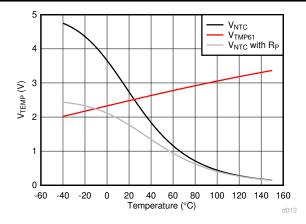


Figure 8-9. NTC With and Without a Linearization Resistor vs TMP61-Q1 Temperature Voltages

#### 8.3.1.2.1 Thermal Protection With Comparator

Use the TMP61-Q1 device along with a voltage reference, and a comparator to program the thermal protection. As shown in Figure 8-10, the output of the comparator remains low until the voltage of the thermistor divider, with  $R_{BIAS}$  and  $R_{TMP61}$ , rises above the threshold voltage set by  $R_1$  and  $R_2$ . When the output goes high, the comparator signals an overtemperature warning signal. The engineer can also program the hysteresis to prevent the output from continuously toggling around the temperature threshold when the output returns low. Either a comparator with built-in hysteresis or feedback resistors may be used.

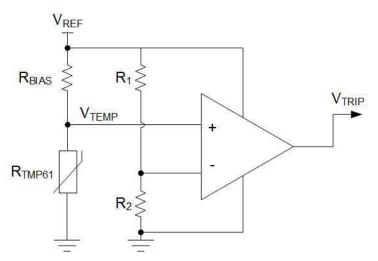


Figure 8-10. Temperature Switch Using TMP61-Q1 Voltage Divider and a Comparator

#### 8.3.1.2.2 Thermal Foldback

One application that uses the output voltage of the TMP61-Q1 in an active control circuit is thermal foldback. This is performed to reduce, or fold back, the current driving a string of LEDs, for example. At high temperatures, the LEDs begin to heat up due to environmental conditions and self heating. Thus, at a certain temperature threshold based on the LED's safe operating area, the driving current must be reduced to cool down the LEDs and prevent thermal runaway. The device voltage output increases with temperature when the output is in the lower position of the voltage divider and can provide a response used to fold back the current. Typically, the device holds the current at a specified level until a high temperature is reached, known as the knee point, at which the current must be rapidly reduced in order to continue operation. To better control the temperature/voltage sensitivity, the device uses a rail-to-rail operational amplifier. Figure 8-11 shows the temperature knee point where the foldback begins. The set by the reference voltage (2.5 V) at the positive input, and the feedback resistors set the response of the foldback curve. The foldback knee point may be chosen based on the output of the voltage divider and the corresponding temperature from Equation 5 (110°C, for example). The device uses a

buffer between the voltage divider with  $R_{TMP61}$  and the input to the op amp to prevent loading and variations in  $V_{TEMP}$ .

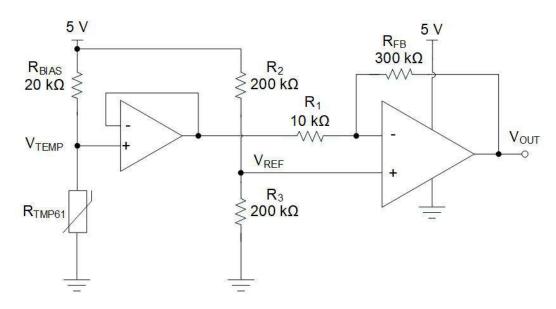


Figure 8-11. Thermal Foldback Using TMP61-Q1 Voltage Divider and a Rail-to-Rail Op Amp

The op amp remains high as long as the voltage output is below  $V_{REF}$ . When the temperature goes above 110°C, the output falls to the 0-V rail of the op amp. The rate at which the foldback occurs depends on the feedback network,  $R_{FB}$  and  $R_1$ , which varies the gain of the op amp, G, as shown in Equation 6. The foldback behavior controls the voltage and temperature sensitivity of the circuit. The device feeds this voltage output into a LED driver circuit that adjusts output current accordingly.  $V_{OUT}$  is the final output voltage used for thermal foldback and is calculated in Equation 7. Figure 8-12 describes the output voltage curve in this example which sets the knee point at 110°C.

$$V_{TEMP} = V_{BIAS} \times \left( \frac{R_{TMP61}}{R_{TMP61} + R_{BIAS}} \right)$$
 (5)

$$G = \frac{R_{FB}}{R_1} \tag{6}$$

$$V_{OUT} = -G \times V_{TEMP} + (1+G) \times V_{REF}$$
(7)



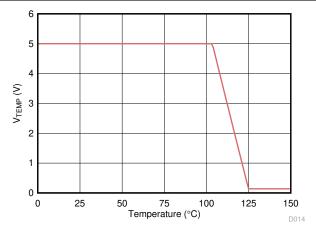


Figure 8-12. Thermal Foldback Voltage Output Curve

### 8.3.1.3 Application Curve

The TMP61-Q1 accuracy varies depending on the selected biasing circuit. This variation can be seen in Figure 8-13.  $V_{TEMP}$  is shown with either  $V_{BIAS}$  at 2 V in a resistor divider circuit ( $R_{BIAS}$  = 10 k $\Omega$  ±1%) or  $I_{BIAS}$  at 200  $\mu$ A. Supply sources used are assumed to be ideal. The best accuracy is achieved using a direct current bias method.

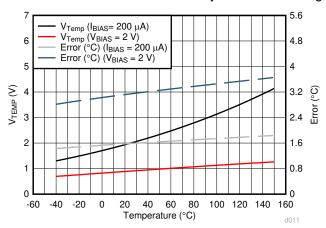


Figure 8-13. TMP61-Q1 Voltage Output and Temperature Error Based on the Bias Method

### 8.4 Power Supply Recommendations

The maximum recommended operating voltage of the TMP61-Q1 is 5.5 V ( $V_{SNS}$ ), and the maximum current through the device is 400  $\mu$ A ( $I_{SNS}$ ).

### 8.5 Layout

### 8.5.1 Layout Guidelines

The layout of the TMP61-Q1 is similar to that of a passive component. If the device is biased with a current source, the positive pin 2 is connected to the source, while the negative pin 1 is connected to ground. If the circuit is biased with a voltage source, and the device is placed on the lower side of the resistor divider, V– is connected to ground and V+ is connected to the output, V<sub>TEMP</sub>. If the device is placed on the upper side of the divider, V+ is connected to the voltage source and V– is connected to the output voltage, V<sub>TEMP</sub>.



## 8.5.2 Layout Examples

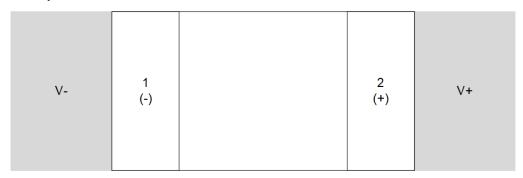


Figure 8-14. Recommended Layout: DEC Package



## 9 Device and Documentation Support

## 9.1 Documentation Support

#### 9.1.1 Related Documentation

For related documentation see the following:

MSL Ratings and Reflow Profiles (SPRABY1)

### 9.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on Notifications to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

## 9.3 Support Resources

TI E2E™ support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the guick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

### 9.4 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

### 9.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

## 9.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

### 10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

С	hanges from Revision F (February 2021) to Revision G (November 2023)	Page
•	Changed table title from Device Information to Package Information	1
•	Added notes to pinout diagrams	
•	Moved the Power Supply Recommendations and Layout sections to the Application and Implementatio	n
	section	18
С	hanges from Revision E (March 2020) to Revision F (February 2021)	Page
•	Added AEC-Q200 Tested to Features	1
•	Added Functional Safety-Capable to Features	1
•	Changed DYA to Grade-0	
•	Updated Device Comparison Table	3
•	Increased Maximum Storage Temperature in Absolute Maximum Ratings Table to 175°C	
•	Changed Max Ambient Temperature from 125 °C to 150 °C for DYA package in Recommended Operat	ing
	Conditions	5
•	Changed DYA package to Grade-0 150 C rating in Recommended Operating Conditions	5
•	Added HTOL and HTSL notes to Recommended Operating Conditions	<u>5</u>
•	Added 1000 hour Long Term Drift specification for DYA package	
•	Updated Typical Characteristics curves	

•	Added QEC-Q200 Qualification feature section.	12
С	hanges from Revision D (February 2020) to Revision E (March 2020)	Page
•	Removed preview notice from the SOT-5X3 package	
•	Updated Description section	
•	Changed minimum Junction Temperature from -40°C to -65°C in Absolute Maximum Ratings table	
•	Changed Max Junction Temperature from 150°C to 155°C in Recommended Operating Conditions	5
С	hanges from Revision C (January 2020) to Revision D (February 2020)	
•	Updated Features list	
•	Updated Applications list	
•	Updated Description	
•	Updated Device Comparison Table ELPG package TA support from 150°C to 170 °C	
•	Added DYA package to Device Comparison Table	
•	Added description for Junction temperature in Absolute Maximum Ratings	
•	Added T <sub>JMAX</sub> spec for Automotive Grade 0 to Absolute Maximum Ratings	
•	Added I <sub>SNS</sub> spec for T <sub>A</sub> = 150 °C to 170 °C to <i>Recommended Operating Conditions</i>	
•	Changed TA description to Automotive Grade 1 in Recommended Operating Conditions	
•	Changed TA description to Automotive Grade 0 in Recommended Operating Conditions	
•	Changed ambient temperature support for Automotive Grade 0 in from 150 °C to 170 °C	
•	Added 'Resistance Tolerance' Spec for T <sub>A</sub> = 150°C to 170°C	
•	Added 'Long Term Drift ' for DYA package	7
•	Changed min spec 'Long Term Drift' for RH = 86 % from 0.1 % to -1 %	
•	Added typical spec 'Long Term Drift' fpr RH = 86 %	7
•	Changed max spec 'Long Term Drift' for RH = 86 % from 0.8 % to 1 %	7
•	Changed min spec 'Long Term Drift' for DEC package from 0.1 % to -1 %	
•	Added typical spec 'Long Term Drift' for DEC package	7
•	Changed max spec 'Long Term Drift' for RH = 86 % from 1 % to 1.8 %	7
•	Changed min spec 'Long Term Drift' for LPG package from 0.1 % to -0.5 %	
•	Changed min spec 'Long Term Drift' for LPG package from 0.1 % to -0.5 %	
•	Added typical spec 'Long Term for Drift' LPG package	
•	Changed max spec 'Long Term Drift' for RH = 86 % from 1.1 % to 1.4 %	
•	Added Added 'Long Term Drift' Spec for ELPG package	
•	Added Automotive Grade 0 typical characteristic curves	
•	Updated Overview section	
•	Added TMP61-Q1 R-T Table section	
•	Updated Feature Description section	
•	Removed Transfer Tables	
•	Added Built-In Fail Safe section	
•	Updated Application and implementation section to match TI data sheet standards	
•	Added link to Thermistor Design tool	
<u>.</u>	Removed Thermal Compensation section	13
С	hanges from Revision B (September 2019) to Revision C (January 2020)	Page
•	Added DYA package in PREVIEW status	4
•	Standardized pinout diagrams	4
•	Clarified Equation 1	10
С	hanges from Revision A (June 2019) to Revision B (September 2019)	Page
•	Changed data sheet status from Production Mixed to Production Data	
•	Added preview SOT-5X3 package	
•	Removed 'Functional, Unspecified Performance' rows	
•	Removed 'Functional, Unspecified Performance' rows	
•	Added 'Long Term Drift' spec for LPG package	



Added Thermal Response Time graphs for the LPG package      Added transfer tables for the LPG package	
Changes from Revision * (April 2019) to Revision A (June 2019)	Page
Changed device status from Advanced Information to Production Data	1

# 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com 9-Nov-2025

#### PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/			Part marking
	(1)	(2)			(3)	Ball material	Peak reflow		(6)
						(4)	(5)		
TMP6131ELPGMQ1	Active	Production	TO-92 (LPG)   2	3000   AMMO	Yes	SN	N/A for Pkg Type	-40 to 170	TMP61
TMP6131ELPGMQ1.A	Active	Production	TO-92 (LPG)   2	3000   AMMO	Yes	SN	N/A for Pkg Type	-40 to 170	TMP61
TMP6131QDECRQ1	Active	Production	X1SON (DEC)   2	10000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	EL
TMP6131QDECRQ1.A	Active	Production	X1SON (DEC)   2	10000   LARGE T&R	Yes	NIPDAU	Level-1-260C-UNLIM	-40 to 125	EL
TMP6131QDECTQ1	Obsolete	Production	X1SON (DEC)   2	-	-	Call TI	Call TI	-40 to 125	EL
TMP6131QDYARQ1	Active	Production	SOT-5X3 (DYA)   2	3000   LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	1GK
TMP6131QDYARQ1.A	Active	Production	SOT-5X3 (DYA)   2	3000   LARGE T&R	Yes	SN	Level-3-260C-168 HR	-40 to 150	1GK
TMP6131QLPGMQ1	Active	Production	TO-92 (LPG)   2	3000   AMMO	Yes	SN	N/A for Pkg Type	-40 to 125	TMP61
TMP6131QLPGMQ1.A	Active	Production	TO-92 (LPG)   2	3000   AMMO	Yes	SN	N/A for Pkg Type	-40 to 125	TMP61

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative

<sup>(2)</sup> Material type: When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> MSL rating/Peak reflow: The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

## PACKAGE OPTION ADDENDUM

www.ti.com 9-Nov-2025

and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

#### OTHER QUALIFIED VERSIONS OF TMP61-Q1:

Catalog: TMP61

NOTE: Qualified Version Definitions:

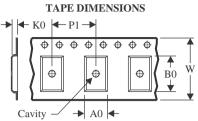
Catalog - TI's standard catalog product

# **PACKAGE MATERIALS INFORMATION**

www.ti.com 20-Feb-2024

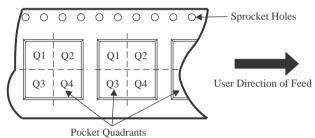
## TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

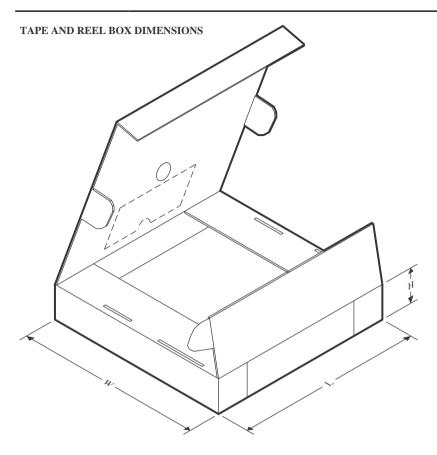
### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
TMP6131QDECRQ1	X1SON	DEC	2	10000	178.0	8.4	0.7	1.15	0.47	2.0	8.0	Q1

www.ti.com 20-Feb-2024

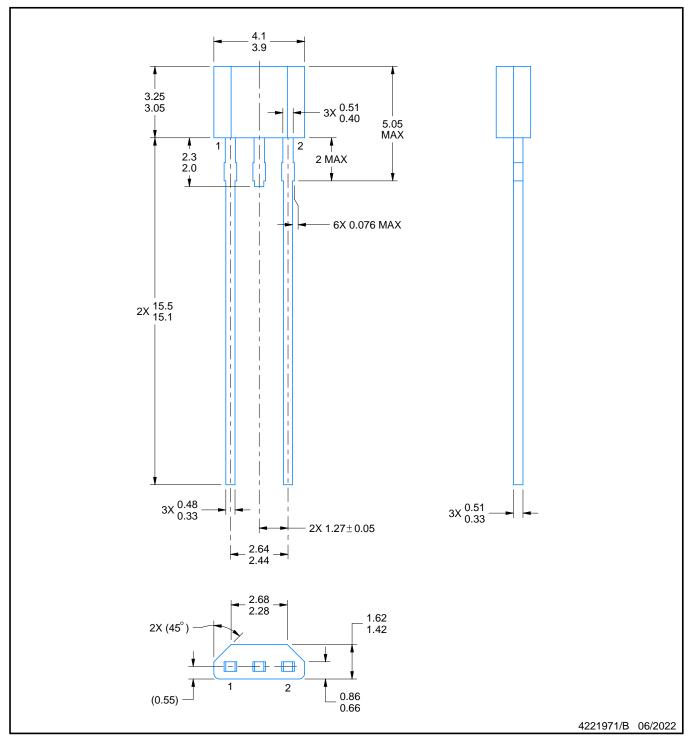


### \*All dimensions are nominal

	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)	
I	TMP6131QDECRQ1	X1SON	DEC	2	10000	205.0	200.0	33.0	



TRANSISTOR OUTLINE



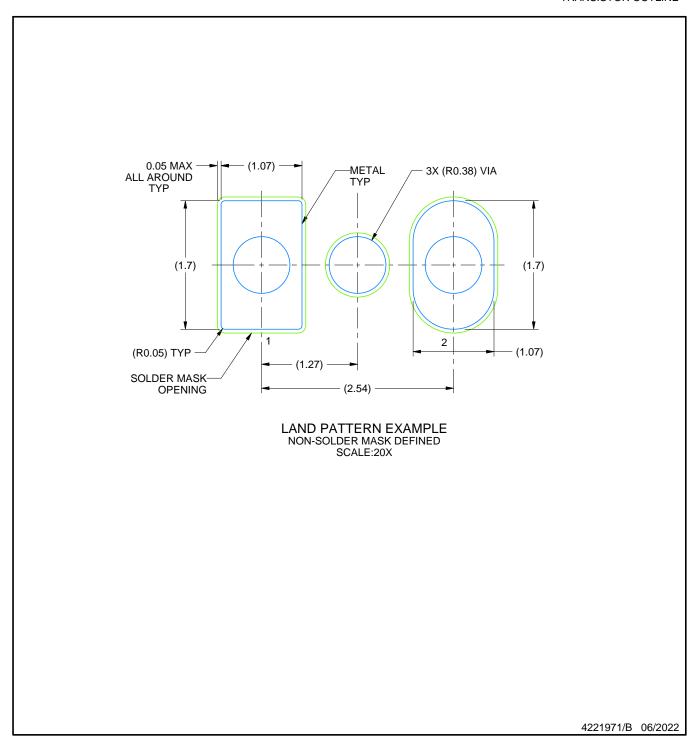
#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M
- per ASME Y14.5M.

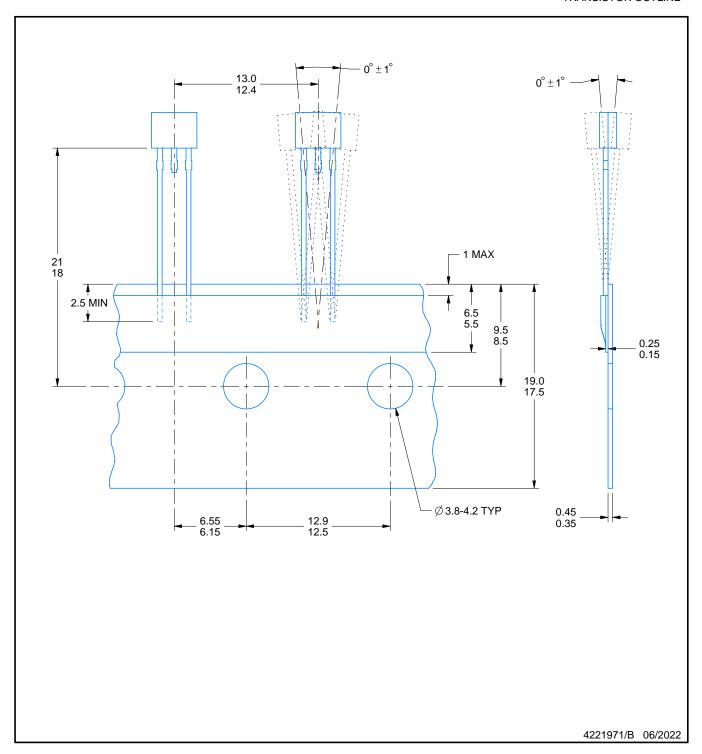
  2. This drawing is subject to change without notice.



TRANSISTOR OUTLINE

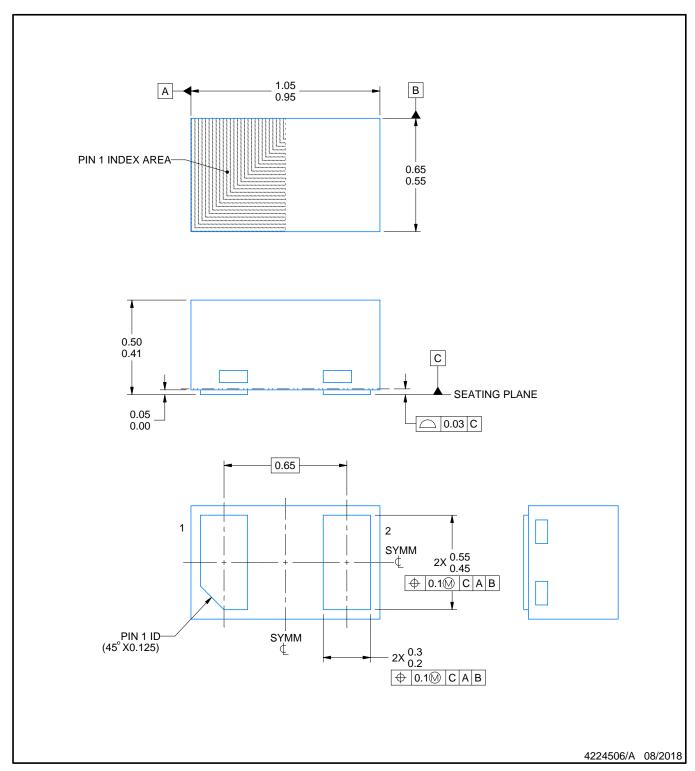


TRANSISTOR OUTLINE





PLASTIC SMALL OUTLINE - NO LEAD

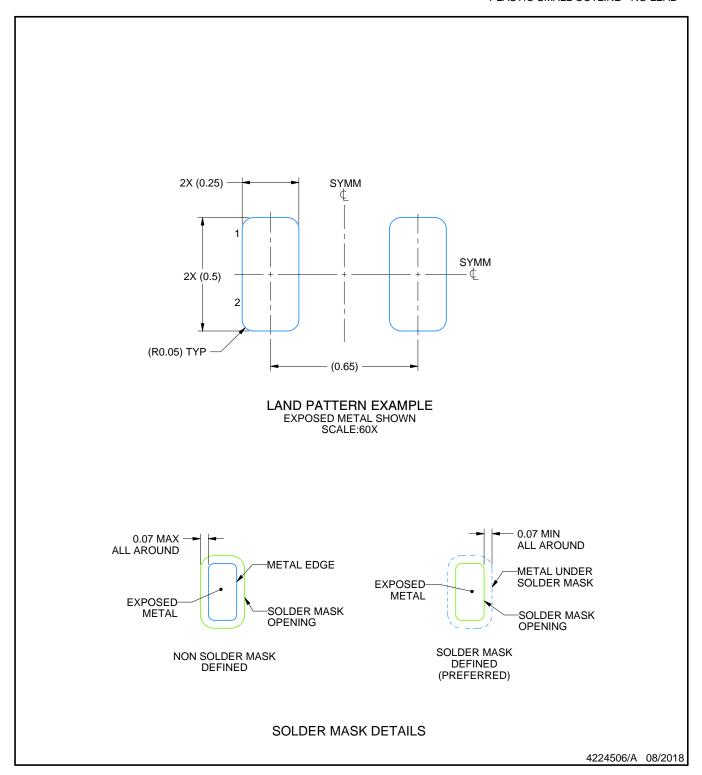


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M
- per ASME Y14.5M
  2. This drawing is subject to change without notice.



PLASTIC SMALL OUTLINE - NO LEAD

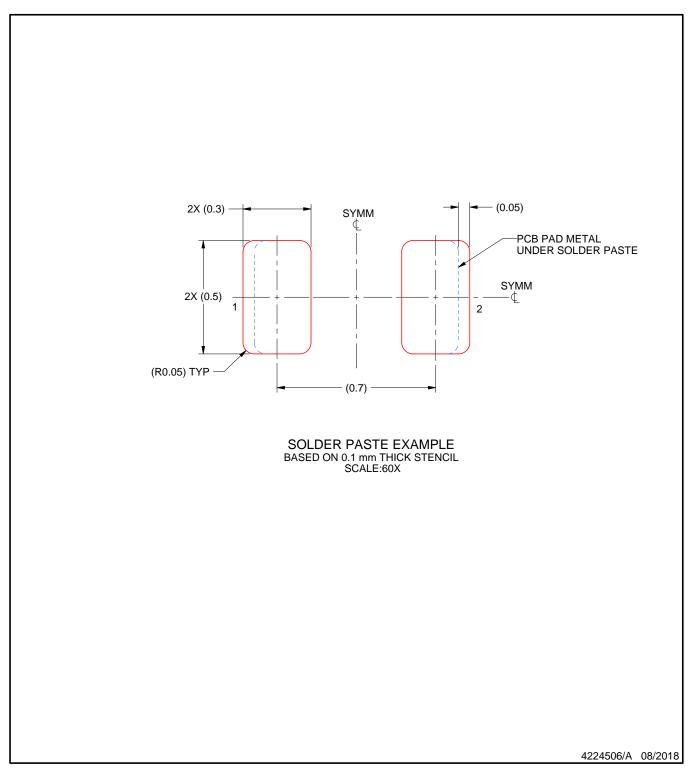


NOTES: (continued)

- 3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).4. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.



PLASTIC SMALL OUTLINE - NO LEAD



NOTES: (continued)

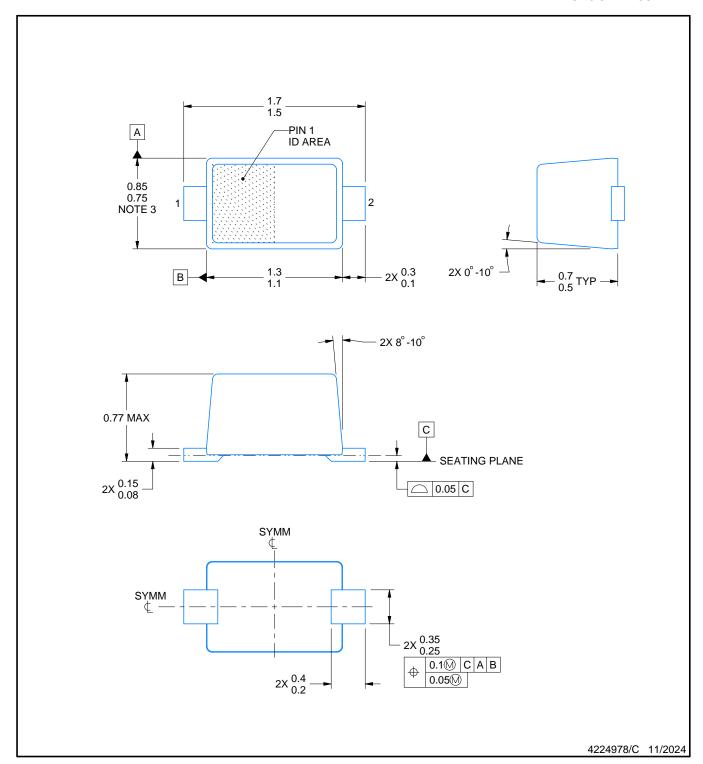
5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.





SOT (SOD-523) - 0.77 mm max height

PLASTIC SMALL OUTLINE



#### NOTES:

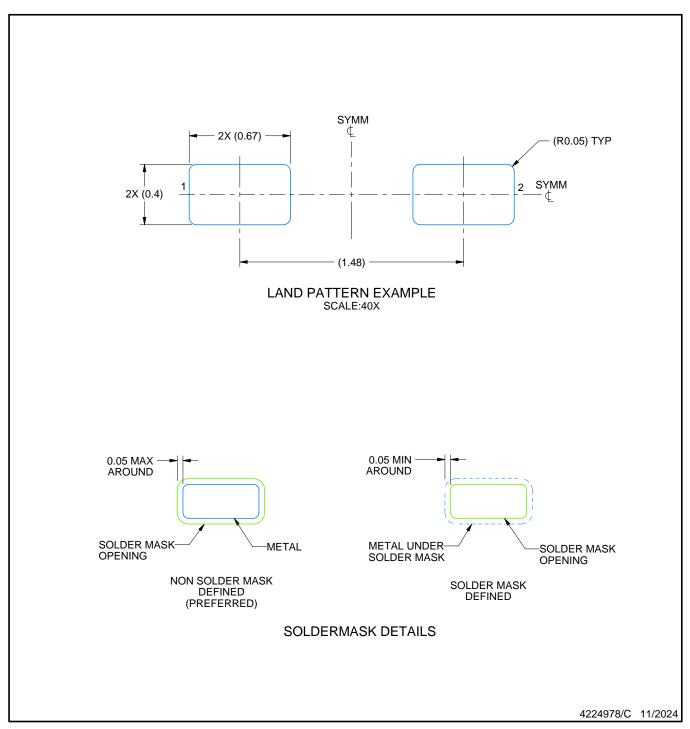
- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. Reference JEITA SC-79 registration except for package height



PLASTIC SMALL OUTLINE

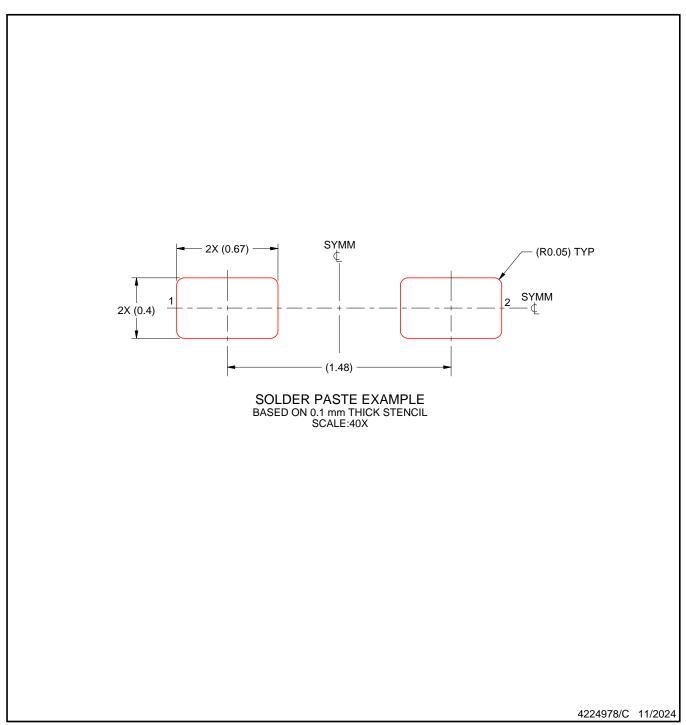


NOTES: (continued)

- 5. Publication IPC-7351 may have alternate designs.
- 6. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



PLASTIC SMALL OUTLINE



NOTES: (continued)



<sup>7.</sup> Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

<sup>8.</sup> Board assembly site may have different recommendations for stencil design.

### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, regulatory or other requirements.

These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you fully indemnify TI and its representatives against any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale, TI's General Quality Guidelines, or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products. Unless TI explicitly designates a product as custom or customer-specified, TI products are standard, catalog, general purpose devices.

TI objects to and rejects any additional or different terms you may propose.

Copyright © 2025, Texas Instruments Incorporated

Last updated 10/2025